

Notice of References Cited	Application/Control No. 09/972,229	Applicant(s)/Patent Under Reexamination WEE ET AL.	
	Examiner Eleni A. Shiferaw	Art Unit 2136	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,810,131	10-2004	Nakagawa et al.	382/100
	B	US-6,532,265	03-2003	Van der Auwera et al.	375/240.16
	C	US-6,055,316 A	04-2000	Perlman et al.	380/262
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	Examiner Eleni A. Shiferaw	Art Unit 2136	Page 1 of 2

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	Examiner Eleni A. Shiferaw	Art Unit 2136	Page 2 of 2

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